

# MOS INTEGRATED CIRCUIT

 $\mu$ PD4482161, 4482181, 4482321, 4482361

# **8M-BIT CMOS SYNCHRONOUS FAST SRAM** FLOW THROUGH OPERATION

## **Description**

The  $\mu$ PD4482161 is a 524,288-word by 16-bit, the  $\mu$ PD4482181 is a 524,288-word by 18-bit, the  $\mu$ PD4482321 is a 262,144-word by 32-bit and the  $\mu$ PD4482361 is a 262,144-word by 36-bit synchronous static RAM fabricated with advanced CMOS technology using Full-CMOS six-transistor memory cell.

The  $\mu$ PD4482161,  $\mu$ PD4482321 and  $\mu$ PD4482361 integrate unique synchronous peripheral circuitry, 2-bit burst counter and output buffer as well as SRAM core. All input registers are controlled by a positive edge of the single clock input (CLK).

The  $\mu$ PD4482161,  $\mu$ PD4482181,  $\mu$ PD4482321 and  $\mu$ PD4482361 are suitable for applications which require synchronous operation, high speed, low voltage, high density and wide bit configuration, such as cache and buffer memory.

ZZ has to be set LOW at the normal operation. When ZZ is set HIGH, the SRAM enters Power Down State ("Sleep"). In the "Sleep" state, the SRAM internal state is preserved. When ZZ is set LOW again, the SRAM resumes normal operation.

The  $\mu$ PD4482161,  $\mu$ PD4482181,  $\mu$ PD4482321 and  $\mu$ PD4482361 are packaged in 100-pin PLASTIC LQFP with a 1.4 mm package thickness for high density and low capacitive loading.

#### **Features**

- 3.3 V or 2.5 V core supply
- Synchronous operation
- Operating temperature: T<sub>A</sub> = 0 to 70 °C (-A65, -A75, -A85, -C75, -C85)

 $T_A = -40 \text{ to } +85 \,^{\circ}\text{C} \text{ (-A65Y, -A75Y, -A85Y, -C75Y, -C85Y)}$ 

- Internally self-timed write control
- Burst read / write : Interleaved burst and linear burst sequence
- Fully registered inputs for flow through operation
- All registers triggered off positive clock edge
- 3.3 V or 2.5 V LVTTL Compatible : All inputs and outputs
- Fast clock access time: 6.5 ns (133 MHz), 7.5 ns (117 MHz), 8.5 ns (100 MHz)
- Asynchronous output enable : /G
- Burst sequence selectable : MODE
- Sleep mode : ZZ (ZZ = Open or Low : Normal operation)
- Separate byte write enable: /BW1 to /BW4, /BWE (µPD4482321, µPD4482361)

/BW1, /BW2, /BWE (μPD4482161, μPD4482181)

Global write enable: /GW

- Three chip enables for easy depth expansion
- Common I/O using three state outputs

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Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.



# **★** Ordering Information

(1/2)

| Part number      | Access | Clock     | Core Supply | I/O Interface        | Operating   | Package         |
|------------------|--------|-----------|-------------|----------------------|-------------|-----------------|
|                  | Time   | Frequency | Voltage     |                      | Temperature |                 |
|                  | ns     | MHz       | V           |                      | °C          |                 |
| μPD4482161GF-A65 | 6.5    | 133       | 3.3 ± 0.165 | 3.3 V LVTTL Note     | 0 to 70     | 100-pin PLASTIC |
| μPD4482161GF-A75 | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             | LQFP (14 × 20)  |
| μPD4482161GF-A85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482181GF-A65 | 6.5    | 133       |             | 3.3 V LVTTL Note     |             |                 |
| μPD4482181GF-A75 | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             |                 |
| μPD4482181GF-A85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482321GF-A65 | 6.5    | 133       |             | 3.3 V LVTTL Note     |             |                 |
| μPD4482321GF-A75 | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             |                 |
| μPD4482321GF-A85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482361GF-A65 | 6.5    | 133       |             | 3.3 V LVTTL Note     |             |                 |
| μPD4482361GF-A75 | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             |                 |
| μPD4482361GF-A85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482161GF-C75 | 7.5    | 117       | 2.5 ± 0.125 | 2.5 V LVTTL          |             |                 |
| μPD4482161GF-C85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482181GF-C75 | 7.5    | 117       |             |                      |             |                 |
| μPD4482181GF-C85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482321GF-C75 | 7.5    | 117       |             |                      |             |                 |
| μPD4482321GF-C85 | 8.5    | 100       |             |                      |             |                 |
| μPD4482361GF-C75 | 7.5    | 117       |             |                      |             |                 |
| μPD4482361GF-C85 | 8.5    | 100       |             |                      |             |                 |

Note Although 2.5V LVTTL interface can also be used, a performance becomes equivalent to -A75 (117 MHz).

(2/2)

| Part number       | Access | Clock     | Core Supply | I/O Interface        | Operating   | Package         |
|-------------------|--------|-----------|-------------|----------------------|-------------|-----------------|
|                   | Time   | Frequency | Voltage     |                      | Temperature |                 |
|                   | ns     | MHz       | V           |                      | °C          |                 |
| μPD4482161GF-A65Y | 6.5    | 133       | 3.3 ± 0.165 | 3.3 V LVTTL Note     | -40 to +85  | 100-pin PLASTIC |
| μPD4482161GF-A75Y | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             | LQFP (14 × 20)  |
| μPD4482161GF-A85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482181GF-A65Y | 6.5    | 133       |             | 3.3 V LVTTL Note     |             |                 |
| μPD4482181GF-A75Y | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             |                 |
| μPD4482181GF-A85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482321GF-A65Y | 6.5    | 133       |             | 3.3 V LVTTL Note     |             |                 |
| μPD4482321GF-A75Y | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             |                 |
| μPD4482321GF-A85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482361GF-A65Y | 6.5    | 133       |             | 3.3 V LVTTL Note     |             |                 |
| μPD4482361GF-A75Y | 7.5    | 117       |             | 3.3 V or 2.5 V LVTTL |             |                 |
| μPD4482361GF-A85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482161GF-C75Y | 7.5    | 117       | 2.5 ± 0.125 | 2.5 V LVTTL          |             |                 |
| μPD4482161GF-C85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482181GF-C75Y | 7.5    | 117       |             |                      |             |                 |
| μPD4482181GF-C85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482321GF-C75Y | 7.5    | 117       |             |                      |             |                 |
| μPD4482321GF-C85Y | 8.5    | 100       |             |                      |             |                 |
| μPD4482361GF-C75Y | 7.5    | 117       |             |                      |             |                 |
| μPD4482361GF-C85Y | 8.5    | 100       |             |                      |             |                 |

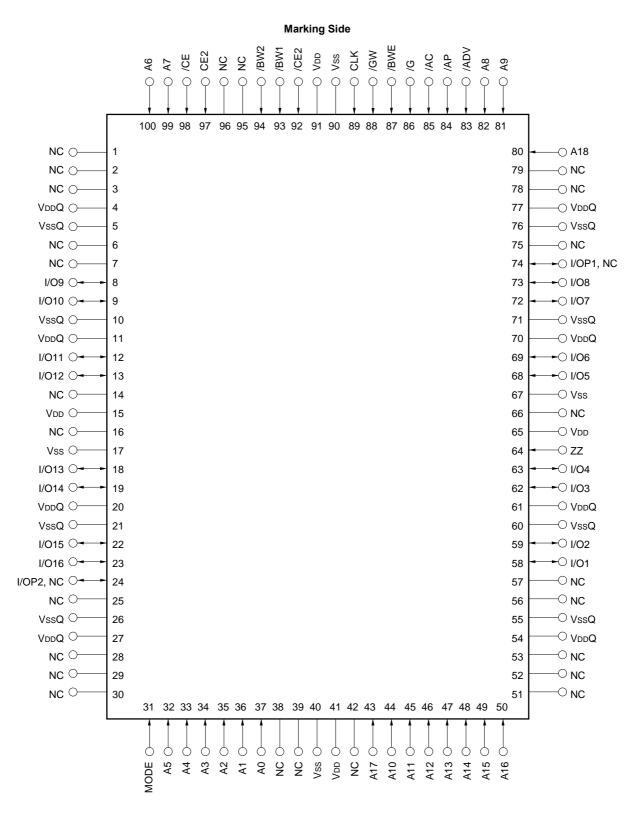
Note Although 2.5V LVTTL interface can also be used, a performance becomes equivalent to -A75Y (117 MHz).



## **Pin Configurations**

/xxx indicates active low signal.

# 100-pin PLASTIC LQFP (14 x 20) [μPD4482161GF, μPD4482181GF]



Remark Refer to Package Drawing for the 1-pin index mark.



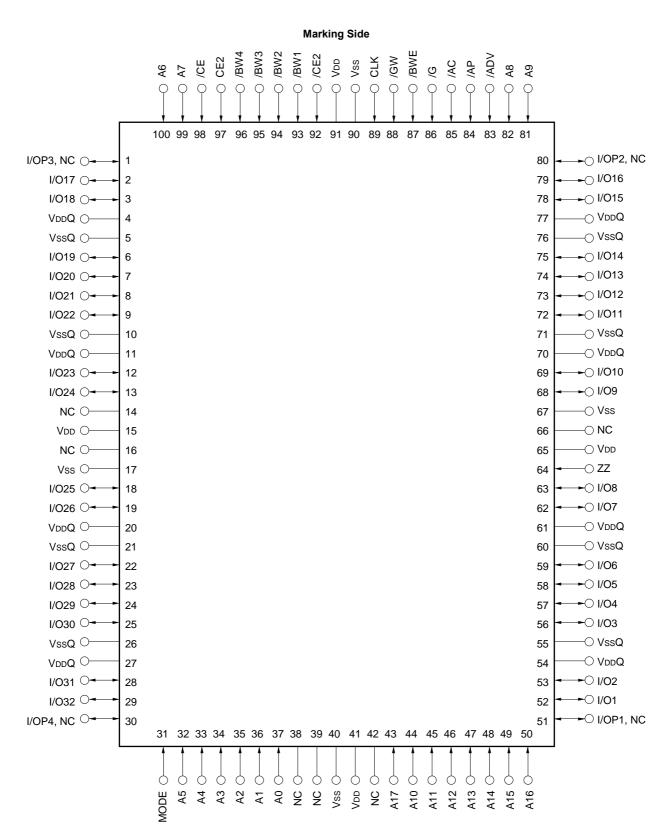
## Pin Identification ( $\mu$ PD4482161GF, $\mu$ PD4482181GF)

| Symbol           | Pin No.                                 | Description                                  |
|------------------|---|--|
| A0 to A18        | 37, 36, 35, 34, 33, 32, 100, 99, 82,    | Synchronous Address Input                    |
|                  | 81, 44, 45, 46, 47, 48, 49, 50, 43, 80  |  |
| I/O1 to I/O16    | 58, 59, 62, 63, 68, 69, 72, 73, 8, 9,   | Synchronous Data In,                         |
|                  | 12, 13, 18, 19, 22, 23                  | Synchronous / Asynchronous Data Out          |
| I/OP1, NC Note   | 74                                      | Synchronous Data In (Parity),                |
| I/OP2, NC Note   | 24                                      | Synchronous / Asynchronous Data Out (Parity) |
| /ADV             | 83                                      | Synchronous Burst Address Advance Input      |
| /AP              | 84                                      | Synchronous Address Status Processor Input   |
| /AC              | 85                                      | Synchronous Address Status Controller Input  |
| /CE, CE2, /CE2   | 98, 97, 92                              | Synchronous Chip Enable Input                |
| /BW1, /BW2, /BWE | 93, 94, 87                              | Synchronous Byte Write Enable Input          |
| /GW              | 88                                      | Synchronous Global Write Input               |
| /G               | 86                                      | Asynchronous Output Enable Input             |
| CLK              | 89                                      | Clock Input                                  |
| MODE             | 31                                      | Asynchronous Burst Sequence Select Input     |
|                  |   | Do not change state during normal operation  |
| ZZ               | 64                                      | Asynchronous Power Down State Input          |
| VDD              | 15, 41, 65, 91                          | Power Supply                                 |
| Vss              | 17, 40, 67, 90                          | Ground                                       |
| VDDQ             | 4, 11, 20, 27, 54, 61, 70, 77           | Output Buffer Power Supply                   |
| VssQ             | 5, 10, 21, 26, 55, 60, 71, 76           | Output Buffer Ground                         |
| NC               | 1, 2, 3, 6, 7, 14, 16, 25, 28, 29, 30,  | No Connection                                |
|                  | 38, 39, 42, 51, 52, 53, 56, 57, 66, 75, |  |
|                  | 78, 79, 95, 96                          |  |

Note NC (No Connection) is used in the  $\mu$ PD4482161GF.

I/OP1 and I/OP2 are used in the  $\mu$ PD4482181GF.

# 100-pin PLASTIC LQFP (14 x 20) [μPD4482321GF, μPD4482361GF]



Remark Refer to Package Drawing for the 1-pin index mark.



## Pin Identification (μPD4482321GF, μPD4482361GF)

| Symbol             | Pin No.                                       | Description                                  |
|--------------------|---|--|
| A0 to A17          | 37, 36, 35, 34, 33, 32, 100, 99, 82, 81, 44,  | Synchronous Address Input                    |
|                    | 45, 46, 47, 48, 49, 50, 43                    |  |
| I/O1 to I/O32      | 52, 53, 56, 57, 58, 59, 62, 63, 68, 69, 72,   | Synchronous Data In,                         |
|                    | 73, 74, 75, 78, 79, 2, 3, 6, 7, 8, 9, 12, 13, | Synchronous / Asynchronous Data Out          |
|                    | 18, 19, 22, 23, 24, 25, 28, 29                |  |
| I/OP1, NC Note     | 51  | Synchronous Data In (Parity),                |
| I/OP2, NC Note     | 80  | Synchronous / Asynchronous Data Out (Parity) |
| I/OP3, NC Note     | 1   |  |
| I/OP4, NC Note     | 30  |  |
| /ADV               | 83  | Synchronous Burst Address Advance Input      |
| /AP                | 84  | Synchronous Address Status Processor Input   |
| /AC                | 85  | Synchronous Address Status Controller Input  |
| /CE, CE2, /CE2     | 98, 97, 92                                    | Synchronous Chip Enable Input                |
| /BW1 to /BW4, /BWE | 93, 94, 95, 96, 87                            | Synchronous Byte Write Enable Input          |
| /GW                | 88  | Synchronous Global Write Input               |
| /G                 | 86  | Asynchronous Output Enable Input             |
| CLK                | 89  | Clock Input                                  |
| MODE               | 31  | Asynchronous Burst Sequence Select Input     |
|                    |   | Do not change state during normal operation  |
| ZZ                 | 64  | Asynchronous Power Down State Input          |
| VDD                | 15, 41, 65, 91                                | Power Supply                                 |
| Vss                | 17, 40, 67, 90                                | Ground                                       |
| VDDQ               | 4, 11, 20, 27, 54, 61, 70, 77                 | Output Buffer Power Supply                   |
| VssQ               | 5, 10, 21, 26, 55, 60, 71, 76                 | Output Buffer Ground                         |
| NC                 | 14, 16, 38, 39, 42, 66                        | No Connection                                |

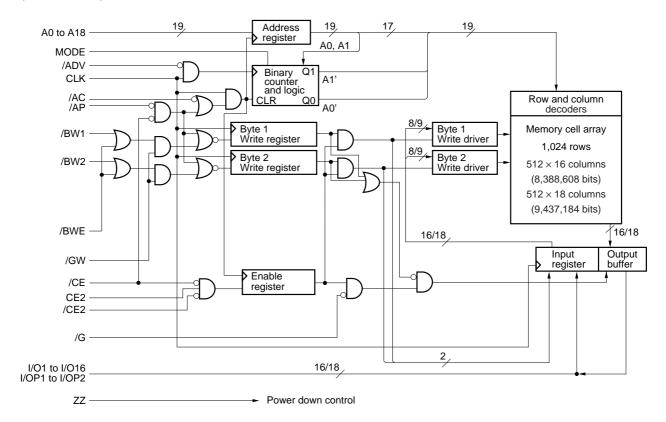
Note NC (No Connection) is used in the  $\mu\text{PD4482321GF}.$ 

I/OP1 to I/OP4 are used in the  $\mu$ PD4482361GF.



## **Block Diagrams**

## [μPD4482161, μPD4482181]



## **Burst Sequence**

## [μPD4482161, μPD4482181]

## Interleaved Burst Sequence Table (MODE = VDD)

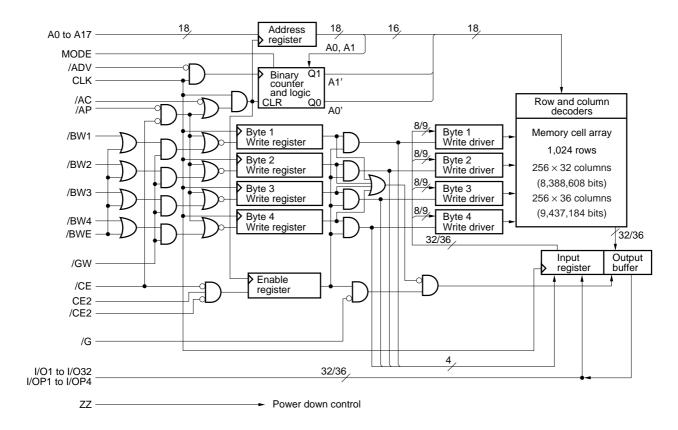
| External Address  | A18 to A2, A1, A0   |
|-------------------|---------------------|
| 1st Burst Address | A18 to A2, A1, /A0  |
| 2nd Burst Address | A18 to A2, /A1, A0  |
| 3rd Burst Address | A18 to A2, /A1, /A0 |

## Linear Burst Sequence Table (MODE = Vss)

| External Address  | A18 to A2, 0, 0 | A18 to A2, 0, 1 | A18 to A2, 1, 0 | A18 to A2, 1, 1 |
|-------------------|-----------------|-----------------|-----------------|-----------------|
| 1st Burst Address | A18 to A2, 0, 1 | A18 to A2, 1, 0 | A18 to A2, 1, 1 | A18 to A2, 0, 0 |
| 2nd Burst Address | A18 to A2, 1, 0 | A18 to A2, 1, 1 | A18 to A2, 0, 0 | A18 to A2, 0, 1 |
| 3rd Burst Address | A18 to A2, 1, 1 | A18 to A2, 0, 0 | A18 to A2, 0, 1 | A18 to A2, 1, 0 |



### [μPD4482321, μPD4482361]



### **Burst Sequence**

## [μPD4482321, μPD4482361]

## Interleaved Burst Sequence Table (MODE = VDD)

| External Address  | A17 to A2, A1, A0   |
|-------------------|---------------------|
| 1st Burst Address | A17 to A2, A1, /A0  |
| 2nd Burst Address | A17 to A2, /A1, A0  |
| 3rd Burst Address | A17 to A2, /A1, /A0 |

## Linear Burst Sequence Table (MODE = Vss)

| External Address  | A17 to A2, 0, 0 | A17 to A2, 0, 1 | A17 to A2, 1, 0 | A17 to A2, 1, 1 |
|-------------------|-----------------|-----------------|-----------------|-----------------|
| 1st Burst Address | A17 to A2, 0, 1 | A17 to A2, 1, 0 | A17 to A2, 1, 1 | A17 to A2, 0, 0 |
| 2nd Burst Address | A17 to A2, 1, 0 | A17 to A2, 1, 1 | A17 to A2, 0, 0 | A17 to A2, 0, 1 |
| 3rd Burst Address | A17 to A2, 1, 1 | A17 to A2, 0, 0 | A17 to A2, 0, 1 | A17 to A2, 1, 0 |



## **Asynchronous Truth Table**

| Operation   | /G | I/O         |
|-------------|----|-------------|
| Read Cycle  | L  | Dout        |
| Read Cycle  | Н  | High-Z      |
| Write Cycle | ×  | High-Z, Din |
| Deselected  | ×  | High-Z      |

Remark ×: don't care

## **Synchronous Truth Table**

| Operation                    | /CE | CE2 | /CE2 | /AP | /AC | /ADV | WRITE | CLK               | Address  |
|------------------------------|-----|-----|------|-----|-----|------|-------|-------------------|----------|
| Deselected Note              | Н   | ×   | ×    | ×   | L   | ×    | ×     | $L \rightarrow H$ | None     |
| Deselected Note              | L   | L   | ×    | L   | ×   | ×    | ×     | $L \rightarrow H$ | None     |
| Deselected Note              | L   | ×   | Н    | L   | ×   | ×    | ×     | $L \rightarrow H$ | None     |
| Deselected Note              | L   | L   | ×    | Н   | L   | ×    | ×     | $L \rightarrow H$ | None     |
| Deselected Note              | L   | ×   | Н    | Н   | L   | ×    | ×     | $L \rightarrow H$ | None     |
| Read Cycle / Begin Burst     | L   | Н   | L    | L   | ×   | ×    | ×     | $L\toH$           | External |
| Read Cycle / Begin Burst     | L   | Н   | L    | Н   | L   | ×    | Н     | $L \rightarrow H$ | External |
| Read Cycle / Continue Burst  | ×   | ×   | ×    | Н   | Н   | L    | Н     | $L \rightarrow H$ | Next     |
| Read Cycle / Continue Burst  | Н   | ×   | ×    | ×   | Н   | L    | Н     | $L \rightarrow H$ | Next     |
| Read Cycle / Suspend Burst   | ×   | ×   | ×    | Н   | Н   | Н    | Н     | $L \rightarrow H$ | Current  |
| Read Cycle / Suspend Burst   | Н   | ×   | ×    | ×   | Н   | Н    | Н     | $L \rightarrow H$ | Current  |
| Write Cycle / Begin Burst    | L   | Н   | L    | Н   | L   | ×    | L     | $L\toH$           | External |
| Write Cycle / Continue Burst | ×   | ×   | ×    | Н   | Н   | L    | L     | $L \rightarrow H$ | Next     |
| Write Cycle / Continue Burst | Н   | ×   | ×    | ×   | Н   | L    | L     | $L \rightarrow H$ | Next     |
| Write Cycle / Suspend Burst  | ×   | ×   | ×    | Н   | Н   | Н    | L     | $L \rightarrow H$ | Current  |
| Write Cycle / Suspend Burst  | Н   | ×   | ×    | ×   | Н   | Н    | L     | $L \rightarrow H$ | Current  |

Note Deselect status is held until new "Begin Burst" entry.

Remarks 1.  $\times$  : don't care

2. /WRITE = L means any one or more byte write enables (/BW1, /BW2, /BW3 or /BW4) and /BWE are LOW or /GW is LOW.

/WRITE = H means the following two cases.

- (1) /BWE and /GW are HIGH.
- (2) /BW1 to /BW4 and /GW are HIGH, and /BWE is LOW.



## **Partial Truth Table for Write Enables**

## [μPD4482161, μPD4482181]

| Operation                                | /GW | /BWE | /BW1 | /BW2 |
|--|-----|------|------|------|
| Read Cycle                               | Н   | Н    | ×    | ×    |
| Read Cycle                               | Н   | L    | Н    | Н    |
| Write Cycle / Byte 1 (I/O [1:8], I/OP1)  | Н   | L    | L    | Н    |
| Write Cycle / Byte 2 (I/O [9:16], I/OP2) | Н   | L    | Н    | L    |
| Write Cycle / All Bytes                  | Н   | L    | L    | L    |
| Write Cycle / All Bytes                  | L   | ×    | ×    | ×    |

 $\textbf{Remark} \ \times : don't \ care$ 

## [μPD4482321, μPD4482361]

| Operation                                 | /GW | /BWE | /BW1 | /BW2 | /BW3 | /BW4 |
|---|-----|------|------|------|------|------|
| Read Cycle                                | Н   | Н    | ×    | ×    | ×    | ×    |
| Read Cycle                                | Н   | L    | Н    | Н    | Н    | Н    |
| Write Cycle / Byte 1 (I/O [1:8], I/OP1)   | Н   | L    | L    | Н    | Н    | Н    |
| Write Cycle / Byte 2 (I/O [9:16], I/OP2)  | Н   | L    | Н    | L    | Н    | Н    |
| Write Cycle / Byte 3 (I/O [17:24], I/OP3) | Н   | L    | Н    | Н    | L    | Н    |
| Write Cycle / Byte 4 (I/O [25:32], I/OP4) | Н   | L    | Н    | Н    | Н    | L    |
| Write Cycle / All Bytes                   | Н   | L    | L    | L    | L    | L    |
| Write Cycle / All Bytes                   | L   | ×    | ×    | ×    | ×    | ×    |

Remark ×: don't care

ZZ (Sleep) Truth Table

| ZZ                        | Chip Status |
|---------------------------|-------------|
| ≤ 0.2 V                   | Active      |
| Open                      | Active      |
| ≥ V <sub>DD</sub> – 0.2 V | Sleep       |



### **Electrical Specifications**

### **Absolute Maximum Ratings**

Parameter Symbol Conditions MIN. TYP. MAX. Unit Notes Supply voltage  $V_{DD}$ -A65, -A75, -A85 -0.5 +4.0 -A65Y, -A75Y, -A85Y -C75, -C85 ٧ -0.5+3.0 -C75Y, -C85Y Output supply voltage  $V_{DD}Q$ -0.5Input voltage  $V_{IN}$ -0.5  $V_{DD} + 0.5$ ٧ 1, 2 Input / Output voltage VI/O -0.5 VDDQ + 0.5 1, 2 °C Operating ambient TΑ 0 -A65, -A75, -A85, -C75, -C85 70 temperature -A65Y, -A75Y, -A85Y, -C75Y, -C85Y -40 +85 Storage temperature Tstg -55 +125 °C

Notes 1. -2.0 V (MIN.)(Pulse width: 2 ns)

2. V<sub>DD</sub>Q + 2.3 V (MAX.)(Pulse width : 2 ns)

Caution Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

### **Recommended DC Operating Conditions**

(1/2)

| Parameter                | Symbol | Conditions | -A65, -A75, -A85 |                 | 5                       | Unit |
|--------------------------|--------|------------|------------------|-----------------|-------------------------|------|
|                          |        |            | -A6              | 65Y, -A75Y, -A8 | 35Y                     |      |
|                          |        |            | MIN.             | TYP.            | MAX.                    |      |
| Supply voltage           | VDD    |            | 3.135            | 3.3             | 3.465                   | V    |
| 2.5 V LVTTL interface    |        |            |                  |                 |                         |      |
| Output supply voltage    | VDDQ   |            | 2.375            | 2.5             | 2.9                     | V    |
| High level input voltage | VIH    |            | 1.7              |                 | V <sub>DD</sub> Q + 0.3 | V    |
| Low level input voltage  | VIL    |            | -0.3 Note        |                 | +0.7                    | V    |
| 3.3 V LVTTL interface    |        |            |                  |                 |                         |      |
| Output supply voltage    | VDDQ   |            | 3.135            | 3.3             | 3.465                   | V    |
| High level input voltage | VIH    |            | 2.0              |                 | V <sub>DD</sub> Q + 0.3 | V    |
| Low level input voltage  | VIL    |            | -0.3 Note        |                 | +0.8                    | V    |

Note -0.8 V (MIN.)(Pulse width: 2 ns)

### **Recommended DC Operating Conditions**

(2/2)

| Parameter                | Symbol | Conditions | -C75, -C85   |      |                         | Unit |
|--------------------------|--------|------------|--------------|------|-------------------------|------|
|                          |        |            | -C75Y, -C85Y |      |                         |      |
|                          |        |            | MIN.         | TYP. | MAX.                    |      |
| Supply voltage           | VDD    |            | 2.375        | 2.5  | 2.625                   | V    |
| Output supply voltage    | VDDQ   |            | 2.375        | 2.5  | 2.625                   | V    |
| High level input voltage | VIH    |            | 1.7          |      | V <sub>DD</sub> Q + 0.3 | V    |
| Low level input voltage  | VIL    |            | -0.3 Note    |      | +0.7                    | V    |

Note -0.8 V (MIN.)(Pulse width: 2 ns)



**DC Characteristics (Recommended Operating Conditions Unless Otherwise Noted)** 

| Parameter                 | Symbol                                   | Test condition  | MIN.         | TYP. | MAX. | Unit | Note |   |
|---------------------------|--|---|--------------|------|------|------|------|---|
| Input leakage current     | lu                                       | VIN (except ZZ, MODE) = 0 V                                 | -2           |      | +2   | μΑ   |      |   |
| I/O leakage current       | ILO                                      | VI/O = 0 V to VDDQ, Outputs a                               | -2           |      | +2   | μΑ   |      |   |
| Operating supply current  | IDD                                      | Device selected,  | -A65         |      |      | 250  | mA   |   |
|                           |  | Cycle = MAX.  | -A65Y        |      |      |      |      |   |
|                           |  | $VIN \le VIL \text{ or } VIN \ge VIH,$                      | -A75, -C75   |      |      | 225  |      |   |
|                           |  | II/O = 0 mA   | -A75Y, -C75Y |      |      |      |      |   |
|                           |  |   | -A85, -C85   |      |      | 200  |      |   |
|                           |  |   | -A85Y, -C85Y |      |      |      |      |   |
|                           | IDD1                                     | Suspend cycle, Cycle = MAX                                  | •            |      |      | 150  |      |   |
|                           |  | /AC, /AP, /ADV, /GW, /BWEs                                  | ≥VIH         |      |      |      |      |   |
|                           |  | $VIN \le VIL \text{ or } VIN \ge VIH, II/O = 0$             |              |      |      |      |      |   |
| Standby supply current    | Isb                                      | Device deselected, Cycle = 0                                |              |      | 30   | mA   |      |   |
|                           |  | VIN ≤ VIL or VIN ≥ VIH, All inpo                            |              |      |      |      |      |   |
|                           | ISB1                                     | Device deselected, Cycle = 0                                |              |      | 15   |      |      |   |
|                           |  | $VIN \le 0.2 \text{ V or } VIN \ge VDD - 0.2$               |              |      |      |      |      |   |
|                           |  | V⊮o ≤ 0.2 V, All inputs are sta                             |              |      |      |      |      |   |
|                           | ISB2                                     | Device deselected, Cycle = N                                |              |      | 110  |      |      |   |
|                           |  | $VIN \le VIL \text{ or } VIN \ge VIH$                       |              |      |      |      |      |   |
| Power down supply current | ISBZZ                                    | $ZZ \ge V_{DD} - 0.2 \text{ V}, \text{ V}_{I/O} \le V_{DD}$ | Q + 0.2 V    |      |      | 15   | mA   |   |
| 2.5 V LVTTL interface     |  |   |              |      |      |      |      |   |
| High level output voltage | Vон                                      | Iон = −2.0 mA   |              | 1.7  |      |      | ٧    |   |
|                           |  | Iон = −1.0 mA   |              | 2.1  |      |      |      |   |
| Low level output voltage  | w level output voltage VoL IoL = +2.0 mA |   |              |      |      | 0.7  | V    |   |
|                           |  | IoL = +1.0 mA   |              |      |      | 0.4  |      |   |
| 3.3 V LVTTL interface     |  |   |              |      |      | •    | •    | • |
| High level output voltage | Vон                                      | Iон = -4.0 mA   |              | 2.4  |      |      | V    |   |
| Low level output voltage  | Vol                                      | IoL = +8.0 mA   |              |      |      | 0.4  | V    |   |

# Capacitance (T<sub>A</sub> = 25 °C, f = 1 MHz)

| Parameter                  | Symbol | Test condition | MIN. | TYP. | MAX. | Unit |
|----------------------------|--------|----------------|------|------|------|------|
| Input capacitance          | Cin    | VIN = 0 V      |      |      | 6.0  | pF   |
| Input / Output capacitance | Cı/o   | VI/O = 0 V     |      |      | 8.0  | pF   |
| Clock input capacitance    | Cclk   | Vclk = 0 V     |      |      | 6.0  | pF   |

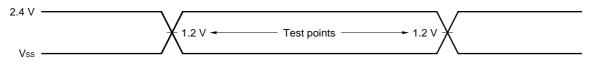
 $\textbf{Remark}\ \ \text{These}\ \text{parameters}\ \text{are}\ \text{periodically}\ \text{sampled}\ \text{and}\ \text{not}\ 100\%\ \text{tested}.$ 

### AC Characteristics (Recommended Operating Conditions Unless Otherwise Noted)

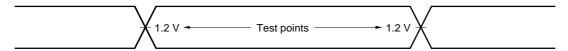
### **AC Test Conditions**

## 2.5 V LVTTL interface

Input waveform (Rise / Fall time ≤ 2.4 ns)

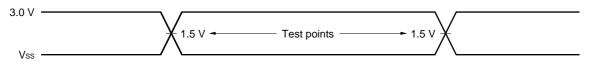


### **Output waveform**

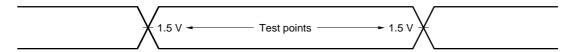


### 3.3 V LVTTL interface

Input waveform (Rise / Fall time ≤ 3.0 ns)



### **Output waveform**

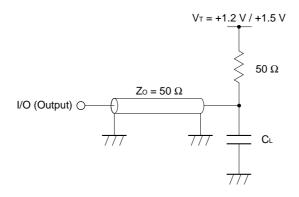


### **Output load condition**

CL: 30 pF

5 pF (TKHQX1, TKHQX2, TGLQX, TGHQZ, TKHQZ)

### **External load at test**



Remark CL includes capacitances of the probe and jig, and stray capacitances.



## Read and Write Cycle (2.5 V LVTTL Interface)

 $\star$ 

| Parameter              |                     | Symbol   |       |           | -A65, -A75, -C75<br>-A65Y, -A75Y, -C75Y |          | -C85<br>-C85Y | Unit | Note |
|------------------------|---------------------|----------|-------|-----------|---|----------|---------------|------|------|
|                        |                     |          |       | (117 MHz) |   | (100MHz) |               |      |      |
|                        |                     | Standard | Alias | MIN.      | MAX.                                    | MIN.     | MAX.          |      |      |
| Cycle time             |                     | TKHKH    | TCYC  | 8.6       | -                                       | 10.0     | -             | ns   |      |
| Clock access           | s time              | TKHQV    | TCD   | -         | 7.5                                     | _        | 8.5           | ns   |      |
| Output enab            | le access time      | TGLQV    | TOE   | -         | 3.5                                     | _        | 3.5           | ns   |      |
| Clock high to          | output active       | TKHQX1   | TDC1  | 2.5       | _                                       | 2.5      | _             | ns   |      |
| Clock high to          | output change       | TKHQX2   | TDC2  | 2.5       | _                                       | 2.5      | -             | ns   |      |
| Output enab            | le to output active | TGLQX    | TOLZ  | 0         | _                                       | 0        | _             | ns   |      |
| Output disab           | le to output High-Z | TGHQZ    | TOHZ  | 0         | 3.5                                     | 0        | 3.5           | ns   |      |
| Clock high to          | output High-Z       | TKHQZ    | TCZ   | 2.5       | 5.0                                     | 2.5      | 5.0           | ns   |      |
| Clock high pulse width |                     | TKHKL    | TCH   | 2.5       | -                                       | 2.5      | -             | ns   |      |
| Clock low pu           | lse width           | TKLKH    | TCL   | 2.5       | _                                       | 2.5      | _             | ns   |      |
| Setup times            | Address             | TAVKH    | TAS   | 1.5       | _                                       | 2.0      | -             | ns   |      |
|                        | Address status      | TADSVKH  | TSS   |           |   |          |               |      |      |
|                        | Data in             | TDVKH    | TDS   |           |   |          |               |      |      |
|                        | Write enable        | TWVKH    | TWS   |           |   |          |               |      |      |
|                        | Address advance     | TADVVKH  | 1     |           |   |          |               |      |      |
|                        | Chip enable         | TEVKH    | 1     |           |   |          |               |      |      |
| Hold times             | Address             | TKHAX    | TAH   | 0.5       | _                                       | 0.5      | _             | ns   |      |
|                        | Address status      | TKHADSX  | TSH   |           |   |          |               |      |      |
|                        | Data in             | TKHDX    | TDH   |           |   |          |               |      |      |
|                        | Write enable        | TKHWX    | TWH   |           |   |          |               |      |      |
|                        | Address advance     | TKHADVX  | -     |           |   |          |               |      |      |
|                        | Chip enable         | TKHEX    | _     |           |   |          |               |      |      |
| Power down             | entry time          | TZZE     | TZZE  | _         | 8.6                                     | _        | 10.0          | ns   |      |
| Power down             | recovery time       | TZZR     | TZZR  | _         | 8.6                                     | _        | 10.0          | ns   |      |

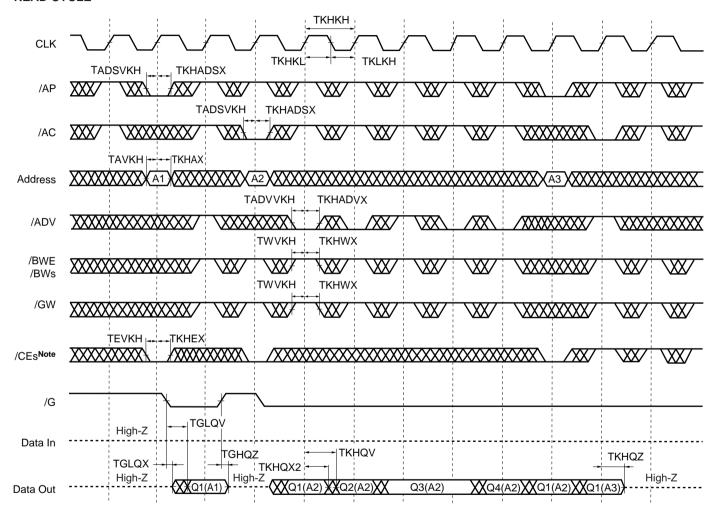


## Read and Write Cycle (3.3 V LVTTL Interface)

| $\boldsymbol{\pi}$ |  |
|--------------------|--|
|                    |  |

| Parameter     |                        | Symb     | ool   | -A65<br>-A65Y<br>(133 MHz) |      | -A75<br>-A75Y<br>(117 MHz) |      | -A85<br>-A85Y<br>(100MHz) |      | Unit | Note |
|---------------|------------------------|----------|-------|----------------------------|------|----------------------------|------|---------------------------|------|------|------|
|               |                        | Standard | Alias | MIN.                       | MAX. | MIN.                       | MAX. | MIN.                      | MAX. |      |      |
| Cycle time    |                        | TKHKH    | TCYC  | 7.5                        | -    | 8.6                        | -    | 10.0                      | -    | ns   |      |
| Clock access  | s time                 | TKHQV    | TCD   | -                          | 6.5  | _                          | 7.5  | _                         | 8.5  | ns   |      |
| Output enabl  | le access time         | TGLQV    | TOE   | _                          | 3.5  | _                          | 3.5  | _                         | 3.5  | ns   |      |
| Clock high to | output active          | TKHQX1   | TDC1  | 2.5                        | _    | 2.5                        | _    | 2.5                       | -    | ns   |      |
| Clock high to | output change          | TKHQX2   | TDC2  | 2.5                        | _    | 2.5                        | _    | 2.5                       | _    | ns   |      |
| Output enab   | le to output active    | TGLQX    | TOLZ  | 0                          | _    | 0                          | _    | 0                         | _    | ns   |      |
| Output disab  | le to output High-Z    | TGHQZ    | TOHZ  | 0                          | 3.5  | 0                          | 3.5  | 0                         | 3.5  | ns   |      |
| Clock high to | output High-Z          | TKHQZ    | TCZ   | 2.5                        | 5.0  | 2.5                        | 5.0  | 2.5                       | 5.0  | ns   |      |
| Clock high p  | Clock high pulse width |          | TCH   | 2.5                        | 1    | 2.5                        | _    | 2.5                       | _    | ns   |      |
| Clock low pu  | lse width              | TKLKH    | TCL   | 2.5                        | 1    | 2.5                        | _    | 2.5                       | _    | ns   |      |
| Setup times   | Address                | TAVKH    | TAS   | 1.5                        | -    | 1.5                        | _    | 2.0                       | _    | ns   |      |
|               | Address status         | TADSVKH  | TSS   |                            |      |                            |      |                           |      |      |      |
|               | Data in                | TDVKH    | TDS   |                            |      |                            |      |                           |      |      |      |
|               | Write enable           | TWVKH    | TWS   |                            |      |                            |      |                           |      |      |      |
|               | Address advance        | TADVVKH  | -     |                            |      |                            |      |                           |      |      |      |
|               | Chip enable            | TEVKH    | -     |                            |      |                            |      |                           |      |      |      |
| Hold times    | Address                | TKHAX    | TAH   | 0.5                        | _    | 0.5                        | -    | 0.5                       | -    | ns   |      |
|               | Address status         | TKHADSX  | TSH   |                            |      |                            |      |                           |      |      |      |
|               | Data in                | TKHDX    | TDH   |                            |      |                            |      |                           |      |      |      |
|               | Write enable           | TKHWX    | TWH   |                            |      |                            |      |                           |      |      |      |
|               | Address advance        | TKHADVX  | _     |                            |      |                            |      |                           |      |      |      |
|               | Chip enable            | TKHEX    | _     |                            |      |                            |      |                           |      |      |      |
| Power down    | entry time             | TZZE     | TZZE  | 1                          | 7.5  | _                          | 8.6  | _                         | 10.0 | ns   |      |
| Power down    | recovery time          | TZZR     | TZZR  | _                          | 7.5  | _                          | 8.6  | _                         | 10.0 | ns   |      |

#### **READ CYCLE**

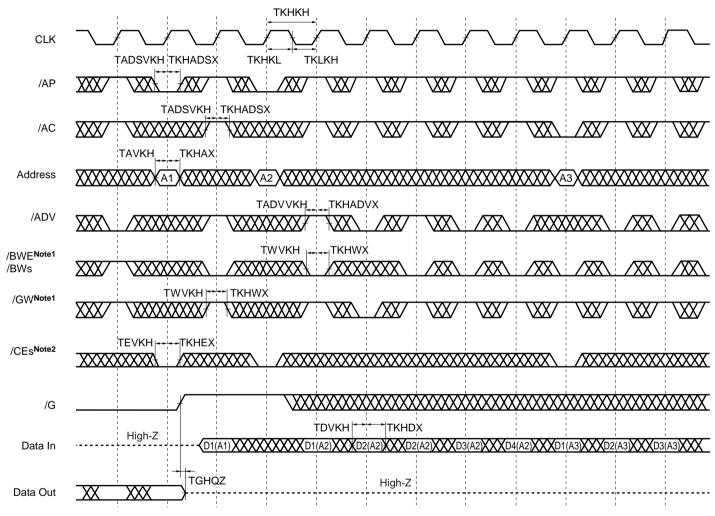


Note /CEs refers to /CE, CE2 and /CE2. When /CEs is LOW, /CE and /CE2 are LOW and CE2 is HIGH. When /CEs is HIGH, /CE and /CE2 are HIGH and CE2 is LOW.

Remark Qn(A2) refers to output from address A2. Q1 to Q4 refer to outputs according to burst sequence.

μPD4482161, 4482181, 4482321, 4482361

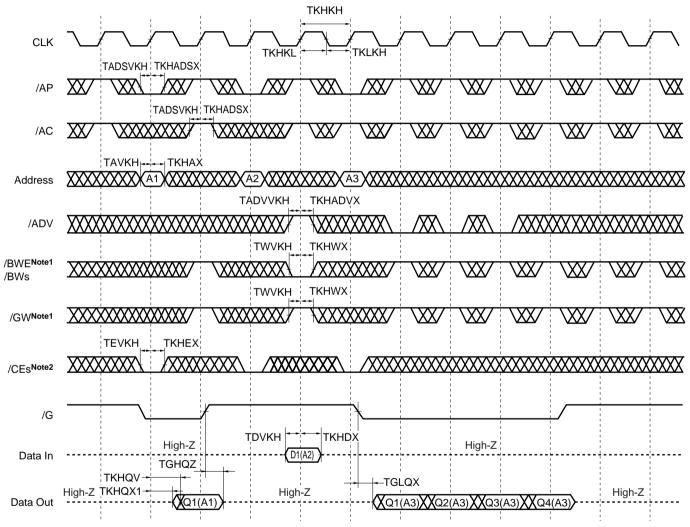
#### **WRITE CYCLE**



Notes 1. All bytes WRITE can be initiated by /GW LOW or /GW HIGH and /BWE, /BW1 to /BW4 LOW.

2. /CEs refers to /CE, CE2 and /CE2. When /CEs is LOW, /CE and /CE2 are LOW and CE2 is HIGH. When /CEs is HIGH. /CE and /CE2 are HIGH and CE2 is LOW.

# **READ / WRITE CYCLE**

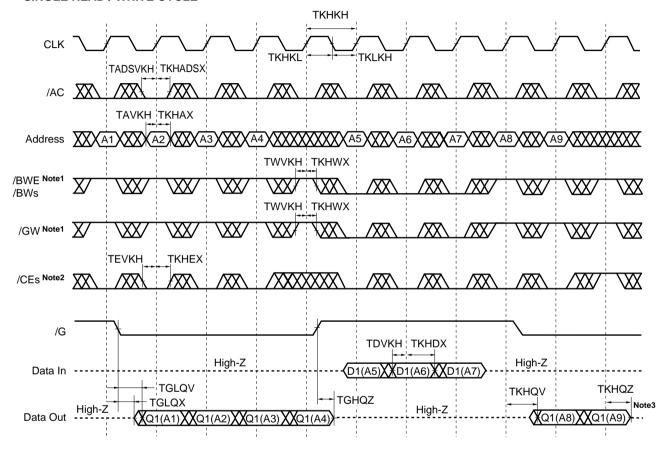


Notes 1. All bytes WRITE can be initiated by /GW LOW or /GW HIGH and /BWE, /BW1 to /BW4 LOW.

2. /CEs refers to /CE, CE2 and /CE2. When /CEs is LOW, /CE and /CE2 are LOW and CE2 is HIGH. When /CEs is HIGH, /CE and /CE2 are HIGH and CE2 is LOW.

μPD4482161, 4482181, 4482321, 4482361

#### **★** SINGLE READ / WRITE CYCLE

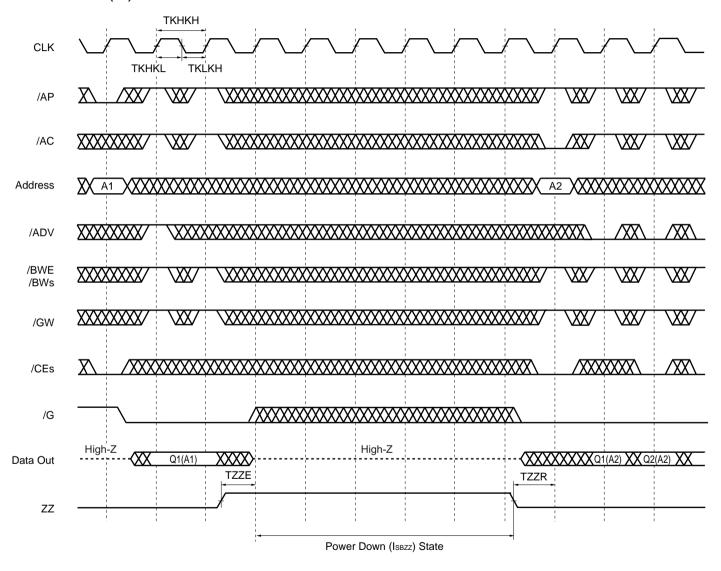


Notes 1. All bytes WRITE can be initiated by /GW LOW or /GW HIGH and /BWE, /BW1 to /BW4 LOW.

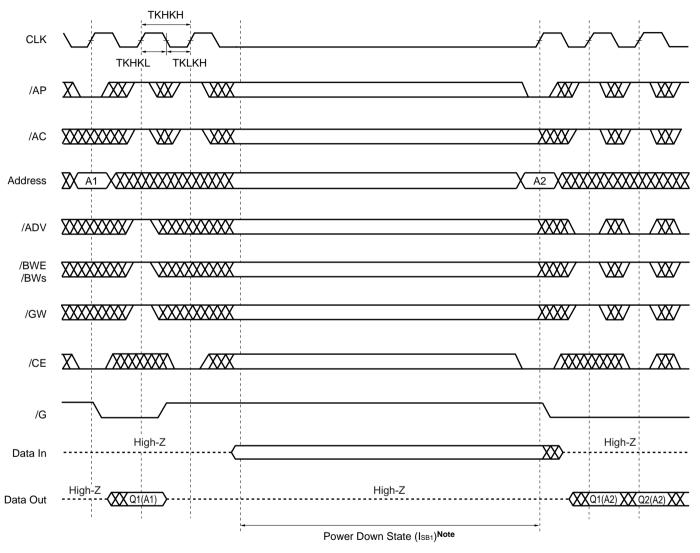
- 2, /CEs refers to /CE, CE2 and /CE2. When /CEs is LOW, /CE and /CE2 are LOW and CE2 is HIGH. When /CEs is HIGH, /CE and /CE2 are HIGH and CE2 is LOW.
- 3. Outputs are disabled within one clock cycle after deselect.

Remark /AP is HIGH and /ADV is don't care.

## **POWER DOWN (ZZ) CYCLE**



µPD4482161, 4482181, 4482321, 4482361

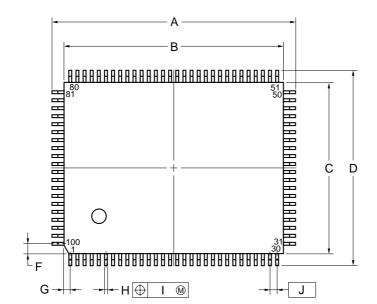


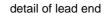
**Note**  $V_{IN} \le 0.2 \text{ V}$  or  $V_{IN} \ge V_{DD} - 0.2 \text{ V}$ ,  $V_{I/O} \le 0.2 \text{ V}$ 

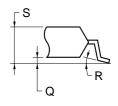


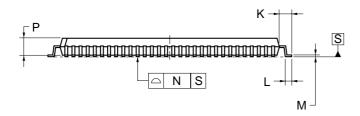
## **Package Drawing**

# 100-PIN PLASTIC LQFP (14x20)









### NOTE

Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material condition.

| ITEM | MILLIMETERS            |
|------|------------------------|
| Α    | 22.0±0.2               |
| В    | 20.0±0.2               |
| С    | 14.0±0.2               |
| D    | 16.0±0.2               |
| F    | 0.825                  |
| G    | 0.575                  |
| Н    | $0.32^{+0.08}_{-0.07}$ |
| I    | 0.13                   |
| J    | 0.65 (T.P.)            |
| K    | 1.0±0.2                |
| L    | 0.5±0.2                |
| М    | $0.17^{+0.06}_{-0.05}$ |
| N    | 0.10                   |
| Р    | 1.4                    |
| Q    | 0.125±0.075            |
| R    | 3°+7°<br>-3°           |
| S    | 1.7 MAX.               |
|      | \$100GE-65-8ET-1       |

S100GF-65-8ET-1

## **Recommended Soldering Condition**

Please consult with our sales offices for soldering conditions of the  $\mu$ PD4482161, 4482321 and 4482361.

## **Types of Surface Mount Devices**

$$\begin{split} \mu \text{PD4482161GF} : 100\text{-pin PLASTIC LQFP (14 x 20)} \\ \mu \text{PD4482181GF} : 100\text{-pin PLASTIC LQFP (14 x 20)} \\ \mu \text{PD4482321GF} : 100\text{-pin PLASTIC LQFP (14 x 20)} \\ \mu \text{PD4482361GF} : 100\text{-pin PLASTIC LQFP (14 x 20)} \end{split}$$



# **Revision History**

| Edition/     | Page       |            | Page         |              | Type of                                       | Location | Description |
|--------------|------------|------------|--------------|--------------|---|----------|-------------|
| Date         | This       | Previous   | revision     |              | (Previous edition $\rightarrow$ This edition) |          |             |
|              | edition    | edition    |              |              |   |          |             |
| 3rd edition/ | Throughout | Throughout | Modification | _            | Preliminary Data Sheet → Data Sheet           |          |             |
| Dec. 2002    |            |            | Addition     | -            | Extended operating temperature products       |          |             |
|              |            |            |              |              | (T <sub>A</sub> = -40 to +85 °C)              |          |             |
|              | p.20       | _          | Addition     | Timing Chart | SINGLE READ / WRITE CYCLE                     |          |             |



[MEMO]

### NOTES FOR CMOS DEVICES —

### (1) PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

#### Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

### (2) HANDLING OF UNUSED INPUT PINS FOR CMOS

#### Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

### (3) STATUS BEFORE INITIALIZATION OF MOS DEVICES

#### Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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